

Applications

- Military radar
- · Civilian radar
- · Professional and military radio communications
- Test instrumentation
- Wideband or narrowband amplifiers
- Jammers



Product Features

• Frequency: DC to 3.5 GHz

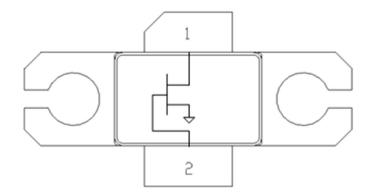
Output Power (P_{3dB}): 107 W at 3.5 GHz

• Linear Gain: > 14 dB at 3.5 GHz • Typical PAE: > 50% at 3.5 GHz

• Operating Voltage: 28 V

Low thermal resistance package

Functional Block Diagram



General Description

The TriQuint TGF2929-FL is a 107 W (P3dB) discrete GaN on SiC HEMT which operates from DC to 3.5 GHz. The device is constructed with TriQuint's proven TQGaN25HV process, which features advanced field plate techniques to optimize power and efficiency at high drain bias operating conditions. This optimization can potentially lower system costs in terms of fewer amplifier line-ups and lower thermal management costs.

Lead-free and ROHS compliant

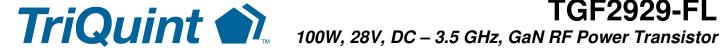
Evaluation boards are available upon request.

Pin Configuration

Pin No.	Label
1	V _D / RF OUT
2	V _G / RF IN
Flange	Source

Ordering Information

Part	ECCN	Description
TGF2929-FL	EAR99	Packaged part Flangeless
TGF2929-FL-EVB1	EAR99	3.1-3.5 GHz Evaluation Board



Absolute Maximum Ratings

Parameter	Value
Breakdown Voltage (BV _{DG})	145 V min.
Gate Voltage Range (V _G)	-10 to 0 V
Drain Current (ID)	12 A
Gate Current (I _G)	-28.8 to 33.6 mA
Power Dissipation (P _D)	144 W
RF Input Power, CW, $T = 25 \degree C (P_{IN})$	39.8 dBm
Channel Temperature (T _{CH})	275 ℃
Mounting Temperature (30 Seconds)	320 ℃
Storage Temperature	-40 to 150 ℃

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

Recommended Operating Conditions

Parameter	Value
Drain Voltage (V _D)	28 V (Typ.)
Drain Quiescent Current (I _{DQ})	260 mA (Typ.)
Peak Drain Current, Pulse (ID)	7.23 A (Typ.)
Gate Voltage (V _G)	-2.9 V (Typ.)
Channel Temperature (T _{CH})	250 °C (Max.)
Power Dissipation, CW (PD)	82 W (Max)
Power Dissipation, Pulse (PD)	140 W (Max)

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

Pulse signal: 100uS Pulse Width, 20% Duty Cycle

RF Characterization – Load Pull Performance at 1 GHz (1)

Test conditions unless otherwise noted: TA = 25 °C, VD = 28 V, IDQ = 260 mA

Symbol	Parameter	Min	Typical	Max	Units
GLIN	Linear Gain (Power Tuned)		21.2		dB
P _{3dB}	Output Power at 3 dB Gain Compression (Power Tuned)		100		W
PAE _{3dB}	Power-Added Efficiency at 3 dB Gain Compression (Eff. Tuned)		75.7		%
G _{3dB}	Gain at 3 dB Compression (Power Tuned)		18.2		dB

Notes:

1. Pulse: 100µs, 20%

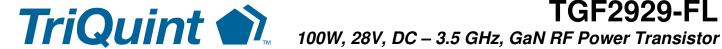
RF Characterization – Load Pull Performance at 2 GHz (1)

Test conditions unless otherwise noted: TA = 25 °C, VD = 28 V, IDQ = 260 mA

Symbol	Parameter	Min	Typical	Max	Units
G _{LIN}	Linear Gain (Power Tuned)		16.7		dB
P _{3dB}	Output Power at 3 dB Gain Compression (Power Tuned)		132		W
PAE _{3dB}	Power-Added Efficiency at 3 dB Gain Compression (Eff. Tuned)		64.4		%
G _{3dB}	Gain at 3 dB Compression (Power Tuned)		13.7		dB

Notes:

1. Pulse: 100µs, 20%



RF Characterization – Load Pull Performance at 3.0 GHz (1)

Test conditions unless otherwise noted: T_A = 25 °C, V_D = 28 V, I_{DQ} = 260 mA

Symbol	Parameter	Min	Typical	Max	Units
GLIN	Linear Gain (Power Tuned)		15.6		dB
P _{3dB}	Output Power at 3 dB Gain Compression (Power Tuned)		120		W
PAE _{3dB}	Power-Added Efficiency at 3 dB Gain Compression (Eff. Tuned)		65.5		%
G _{3dB}	Gain at 3 dB Compression (Power Tuned)		12.6		dB

Notes:

1. Pulse: 100µs, 20%

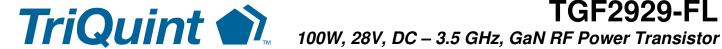
RF Characterization – Load Pull Performance at 3.5 GHz (1)

Test conditions unless otherwise noted: T_A = 25 °C, V_D = 28 V, I_{DQ} = 260 mA

Symbol	Parameter	Min	Typical	Max	Units
GLIN	Linear Gain (Power Tuned)		15.8		dB
P _{3dB}	Output Power at 3 dB Gain Compression (Power Tuned)		107		W
PAE _{3dB}	Power-Added Efficiency at 3 dB Gain Compression (Eff. Tuned)		58.4		%
G _{3dB}	Gain at 3 dB Compression (Power Tuned)		12.8		dB

Notes:

1. Pulse: 100µs, 20%



RF Characterization – Performance at 3.3GHz (1, 2)

Test conditions unless otherwise noted: TA = 25 °C, VD = 28 V, IDQ = 260 mA

Symbol	Parameter	Min	Typical	Max	Units
GLIN	Linear Gain		15.0		dB
P _{3dB}	Output Power at 3 dB Gain Compression		106		W
PAE _{3dB}	Power-Added Efficiency at 3 dB Gain Compression		51.3		%
G _{3dB}	Gain at 3 dB Compression		12.0		dB

Notes:

- 1. Pulse: 100µs PW, 20%
- 2. Performance at 3.3GHz in the 3.1 to 3.5GHz Evaluation Board

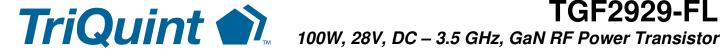
RF Characterization – Mismatched Ruggedness at 3.50 GHz (1, 2)

Test conditions unless otherwise noted: TA = 25 °C, VD = 28 V, IDQ = 260 mA

Symbol	Parameter	Typical
VSWR	Impedance Mismatch Ruggedness	10:1

Notes:

- 1. Input power established at P3dB at matched load at the output of 3.1 3.5 GHz Evaluation Board
- 2. Pulse: 100uS PW, 20%



Thermal and Reliability Information - Pulsed

Parameter	Test Conditions	Value	Units
Thermal Resistance ⁽¹⁾ (θ _{JC})		0.75	°C/W
Channel Temperature (T _{CH})	100uS, 5%, Pdiss = 100W	160	℃
Median Lifetime (T _M)		1.92E09	Hours
Thermal Resistance ⁽¹⁾ (θ _{JC})		0.79	°C/W
Channel Temperature (T _{CH})	100uS, 10%, Pdiss = 100W	164.3	℃
Median Lifetime (T _M)		1.24E09	Hours
Thermal Resistance ⁽¹⁾ (θ _{JC})		0.88	°C/W
Channel Temperature (T _{CH})	300uS, 20%, Pdiss = 100W	173	℃
Median Lifetime (T _M)		5.13E08	Hours
Thermal Resistance ⁽¹⁾ (θ _{JC})		1.15	°C/W
Channel Temperature (T _{CH})	300uS, 50%, Pdiss = 100W	200	℃
Median Lifetime (T _M)		4.20E07	Hours

Notes:

Thermal and Reliability Information - CW ¹

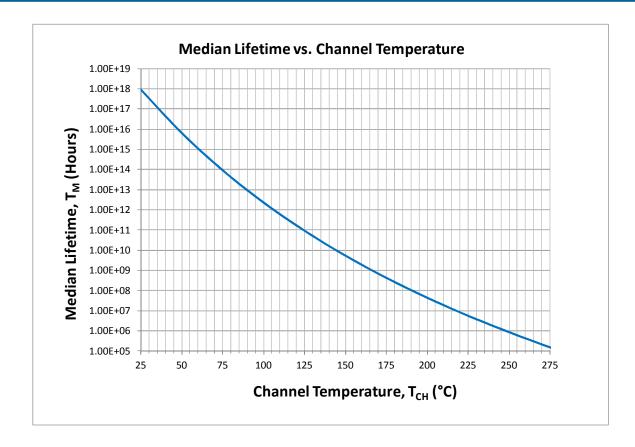
Parameter	Test Conditions	Value	Units
Thermal Resistance (θ _{JC})	05.00.0	0.87	ºC/W
Channel Temperature (T _{CH})	85 °C Case 28.8 W Pdiss	110	℃
Median Lifetime (T _M)	28.6 W Puiss	6.38E11	Hrs
Thermal Resistance (θ _{JC})	05.00.0	1.49	ºC/W
Channel Temperature (T _{CH})	85 ℃ Case 57.6 W Pdiss	171	℃
Median Lifetime (T _M)		6.29E8	Hrs
Thermal Resistance (θ _{JC})	05.00.0	1.62	ºC/W
Channel Temperature (T _{CH})	85 °C Case 86.4 W Pdiss	225	℃
Median Lifetime (T _M)	00.7 W 1 0133	5.49E6	Hrs
Thermal Resistance (θ _{JC})	05.00.0	1.74	ºC/W
Channel Temperature (T _{CH})	85 °C Case 115.2 W Pdiss	285	°C
Median Lifetime (T _M)		7.80E4	Hrs

Notes:

^{1.} Thermal resistance measured to bottom of package.

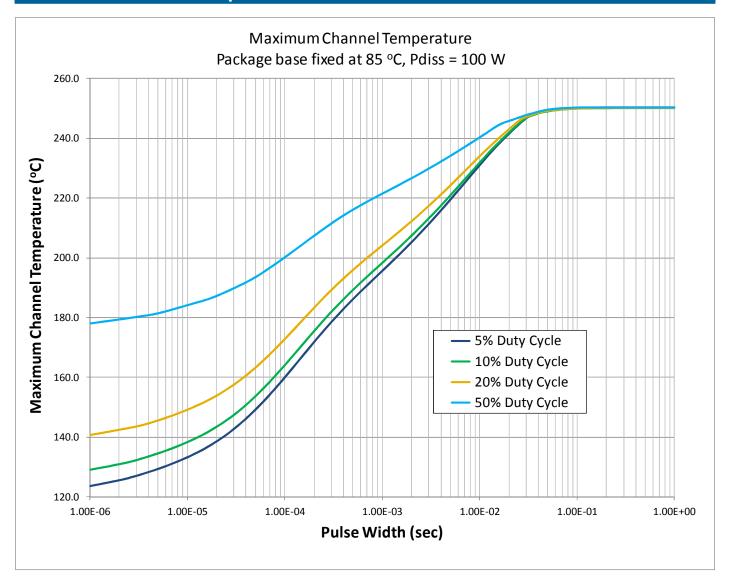
^{1.} Thermal resistance measured to bottom of package.

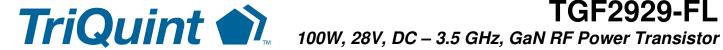
Median Lifetime



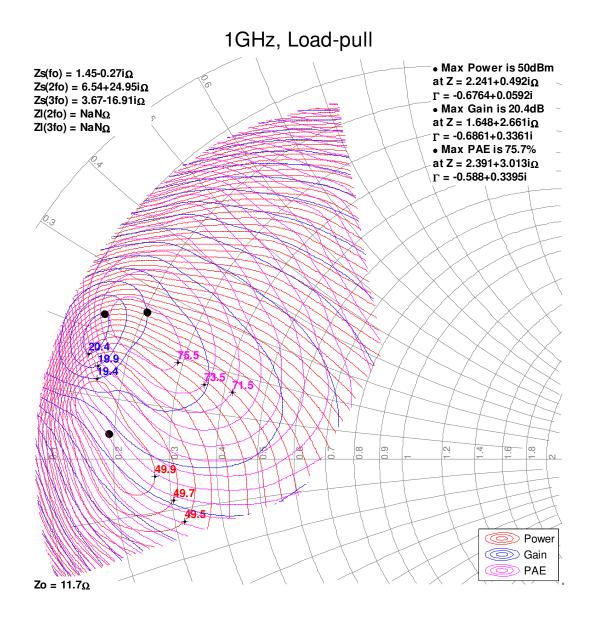


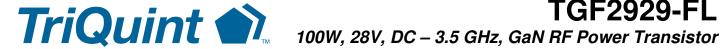
Maximum Channel Temperature - Pulsed



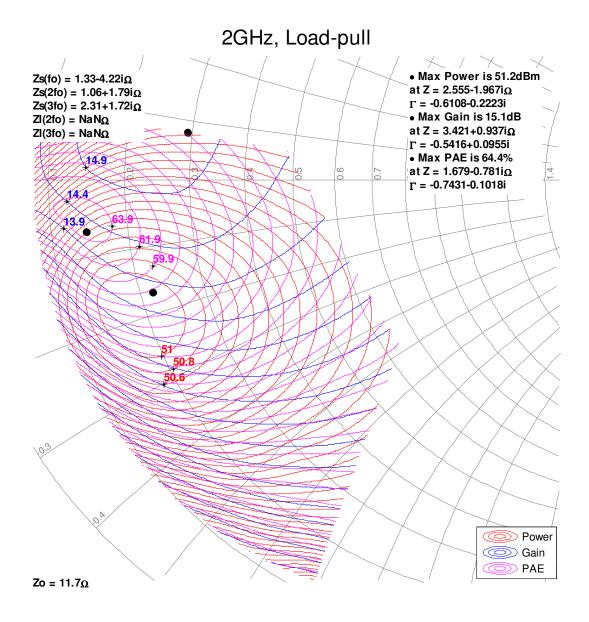


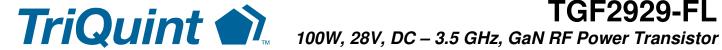
- Test Conditions: V_{DS} = 28 V, I_{DQ} = 260 mA
- Test Signal: Pulse Width = 100 μsec, Duty Cycle = 20%
- NaN indicates the harmonic impedances are uncontrolled.



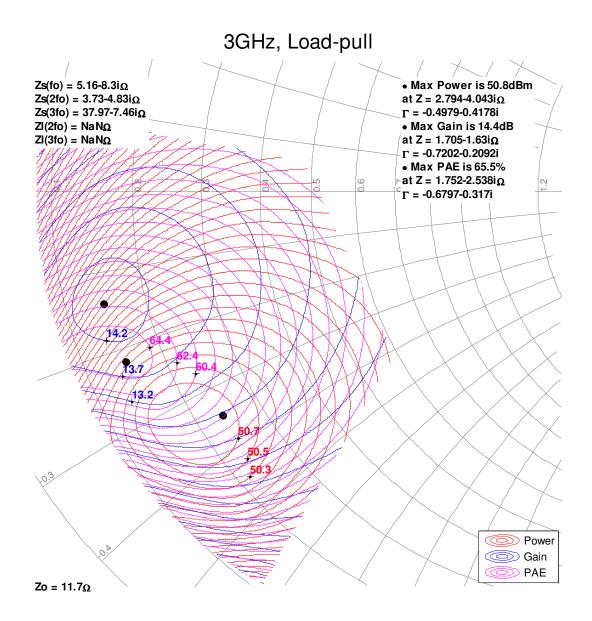


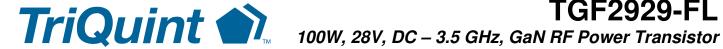
- Test Conditions: V_{DS} = 28 V, I_{DQ} = 260 mA
- Test Signal: Pulse Width = 100 μsec, Duty Cycle = 20%
- NaN indicates the harmonic impedances are uncontrolled.



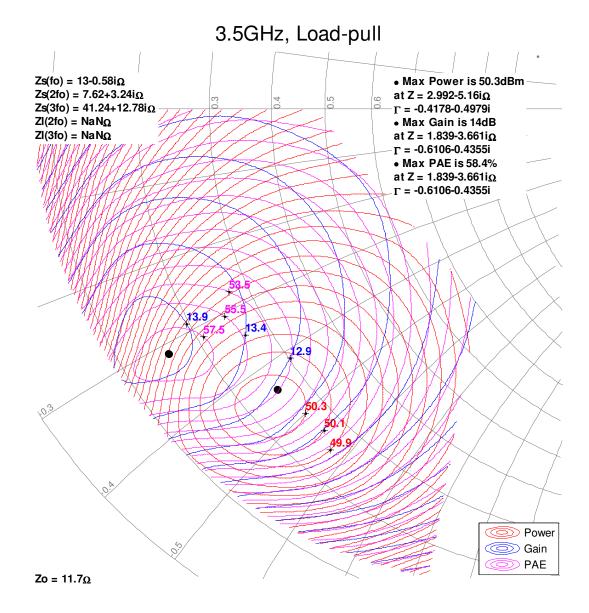


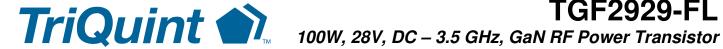
- Test Conditions: V_{DS} = 28 V, I_{DQ} = 260 mA
- Test Signal: Pulse Width = 100 μsec, Duty Cycle = 20%
- NaN indicates the harmonic impedances are uncontrolled.





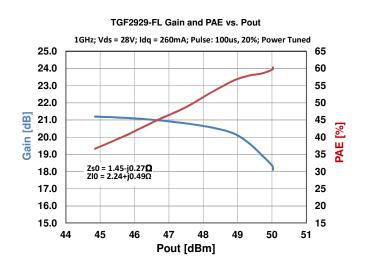
- Test Conditions: V_{DS} = 28 V, I_{DQ} = 260 mA
- Test Signal: Pulse Width = 100 μsec, Duty Cycle = 20%
- NaN indicates the harmonic impedances are uncontrolled.

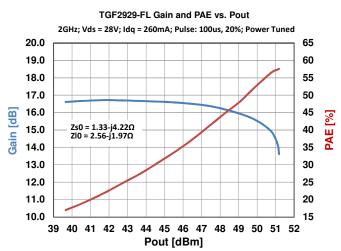


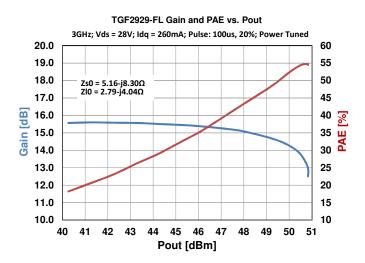


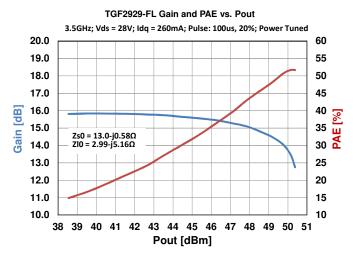
Typical Load-pull Performance – Power Tuned^(1, 2)

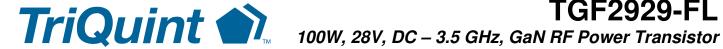
- 1. Vds = 28V, ldq = 260mA, Pulse Width = 100uS, Duty Cycle = 20%, 25°C
- Performance measured at device's reference planes. See page 18.





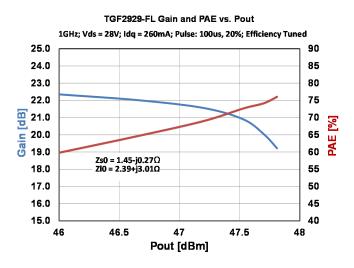


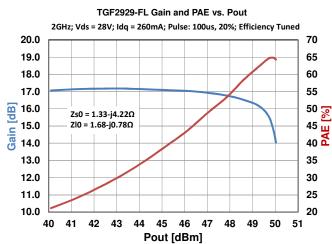


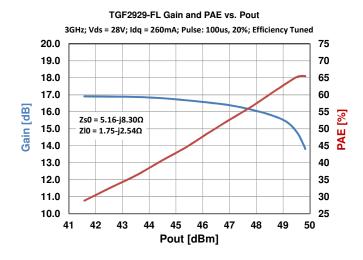


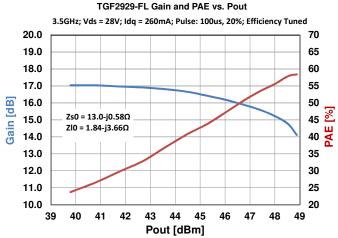
Typical Load-pull Performance – Efficiency Tuned^(1, 2)

- 1. Vds = 28V, ldg = 260mA, Pulse Width = 100uS, Duty Cycle = 20%, 25℃
- 2. Performance measured at device's reference planes. See page 18.



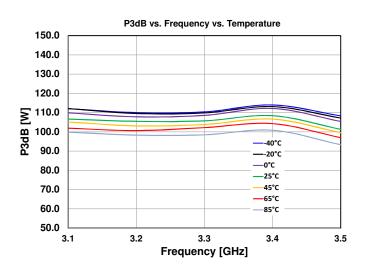


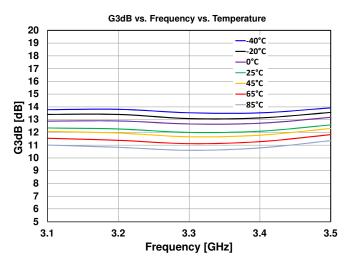


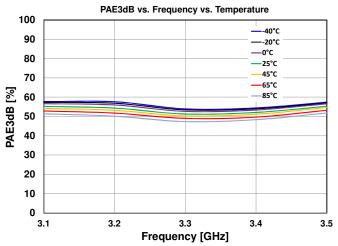


Performance Over Temperature (1, 2)

Performance measured in TriQuint's 3.1 GHz to 3.5 GHz Evaluation Board at 3 dB compression.

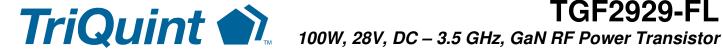






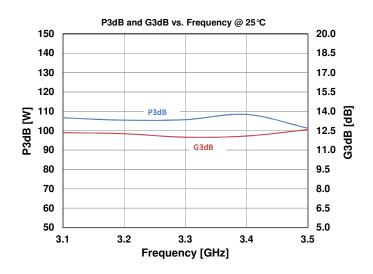
Notes:

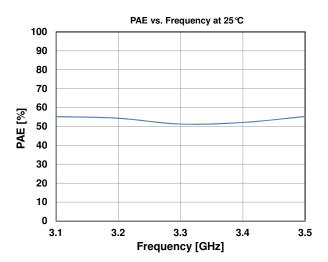
- 1. Test Conditions: $V_{DS} = 28 \text{ V}$, $I_{DQ} = 260 \text{ mA}$
- 2. Test Signal: Pulse Width = 100 μs, Duty Cycle = 20%



Evaluation Board Performance at 25 °C (1, 2)

Performance measured in TriQuint's 3.1 GHz to 3.5 GHz Evaluation Board at 3 dB compression.

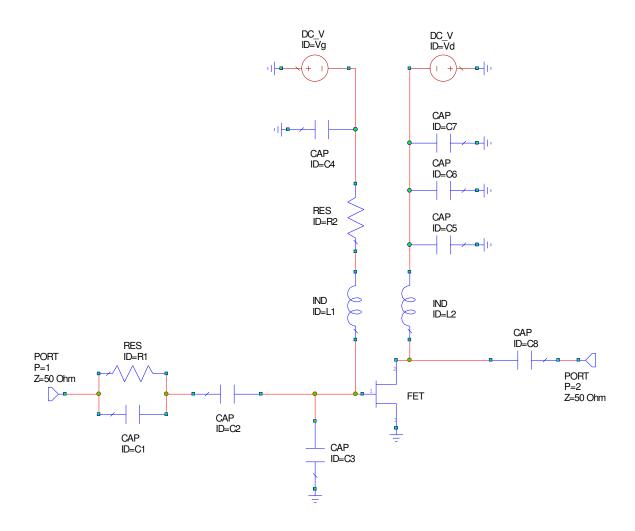




Notes:

- 1. Test Conditions: $V_{DS} = 28 \text{ V}$, $I_{DQ} = 260 \text{ mA}$
- 2. Test Signal: Pulse Width = 100 μs, Duty Cycle = 20 %

Application Circuit



Bias-up Procedure

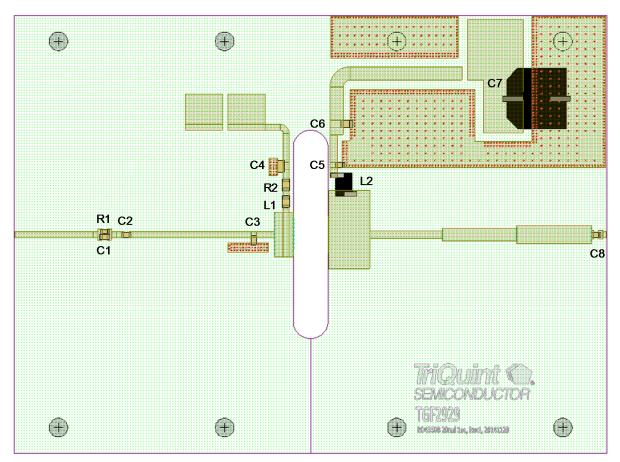
- 1. V_G set to -5 V.
- 2. V_D set to 28 V.
- 3. Adjust V_G more positive until quiescent I_D is 260 mÁ.
- 4. Apply RF signal.

Bias-down Procedure

- 1. Turn off RF signal.
- 2. Turn off V_D and wait 1 second to allow drain capacitor dissipation.
- 3. Turn off V_G.

Evaluation Board Layout

Top RF layer is 0.020" thick Rogers RO4350B, $\varepsilon_r = 3.48$. The pad pattern shown has been developed and tested for optimized assembly at TriQuint Semiconductor. The PCB land pattern has been developed to accommodate lead and package tolerances.



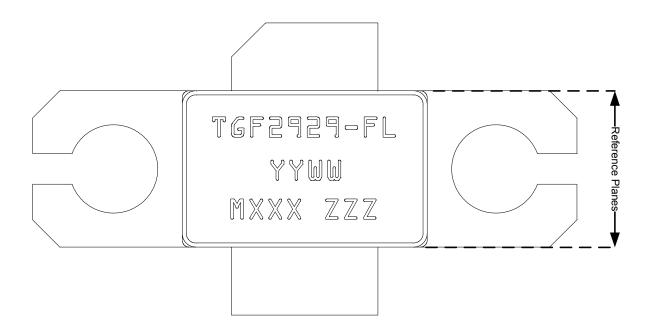
Bill of Materials

Reference Design	Value	Qty	Manufacturer	Part Number
R1	100 Ω	1	Vishay/Dale	CRCW0603100RJNEA
C1, C2	5.6 pF	2	ATC	600S5R6BT
C3	1.0 pF	1	ATC	600S1R0BT
L1	22 nH	1	Coilcraft	0805CS-220X-LB
R2	10 Ω	1	Vishay/Dale	CRCW060310R0JNEA
C4	10 uF	1	Murata	C1632X5R0J106M130AC
L2	12 nH	1	Coilcraft	A04T_L
C5	2400 pF	1	Murata	C08BL242X-5UN-X0T
C6	1000 pF	1	ATC	800B102JT50XT
C7	220 uF	1	United Chemi-Con	EMVY500ADA221MJA0G
C8	15 pF	1	ATC	600S150JT250XT

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Pin Layout

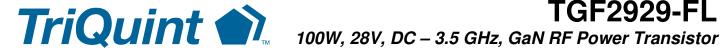


Note:

The TGF2929-FL will be marked with the "TGF2929-FL" designator and a lot code marked below the part designator. The "YY" represents the last two digits of the calendar year the part was manufactured, the "WW" is the work week of the assembly lot start, the "MXXX" is the production lot number, and the "ZZZ" is an auto-generated serial number.

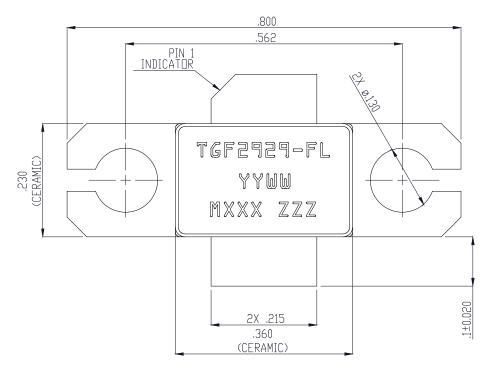
Pin Description

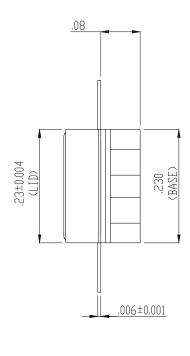
Pin	Symbol	Description
1	V _D / RF OUT	Drain voltage / RF Output
2	V _G / RF IN	Gate voltage / RF
3	Flange	Source connected to ground

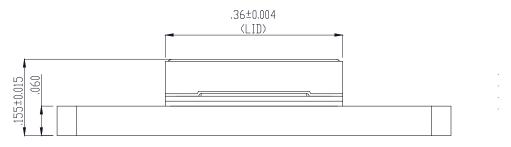


Mechanical Information

All dimensions are in inches.

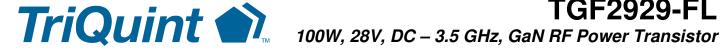






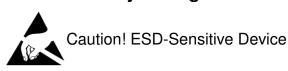
Note:

Unless otherwise noted, all tolerances are +/-0.005 inches. This package is lead-free/RoHS-compliant. The plating material on the leads is NiAu. It is compatible with both lead-free and tin-lead soldering processes.



Product Compliance Information

ESD Sensitivity Ratings



ESD Rating: Class 1B

≥ 500 V and < 1000V Value: Test: Human Body Model (HBM) Standard: JEDEC Standard JESD22-A114

MSL Rating

The part is rated Moisture Sensitivity Level 3 at 260 ℃ per JEDEC standard IPC/JEDEC J-STD-020.

ECCN

US Department of Commerce EAR99

Solderability

Compatible with the latest version of J-STD-020, Lead free solder, 260° C

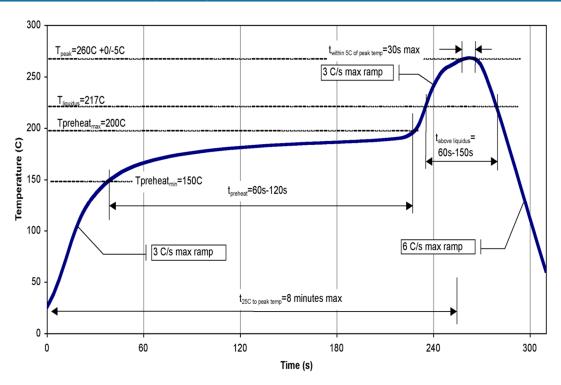
RoHs Compliance

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

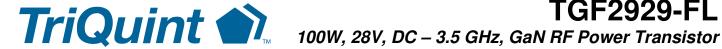
This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C₁₅H₁₂Br₄O₂) Free
- PFOS Free
- SVHC Free

Recommended Soldering Temperature Profile







Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations, and information about TriQuint:

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For technical questions and application information: Email: info-products@triquint.com

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